

Available Online

JOURNAL OF SCIENTIFIC RESEARCH www.banglajol.info/index.php/JSR

J. Sci. Res. 5 (2), 235-244 (2013)

Indexing the Diffraction Patterns and Investigating the Crystal Structure of Pb-doped Strontium Ferrites

Z. Ullah, S. Atiq^{*}, and S. Naseem

Centre of Excellence in Solid State Physics, University of the Punjab, Lahore-54590, Pakistan

Received 7 August 2012, accepted in final revised form 22 February 2013

Abstract

Strontium hexaferrites were prepared in powder form by sol-gel auto-ignition technique and Pb was doped in different concentrations to attain the various compositions $Sr_{1-x}Pb_xFe_{12}O_{19}$ (x = 0.00, 0.05, 0.10, 0.15, 0.20). Sintering treatment of the samples was made at 800 °C for the development of stable hexagonal phase. X-ray diffraction analysis of the samples was carried out for the confirmation and determination of crystal structure of the material. Data obtained from X-ray diffraction analysis helped in determining various parameters of the samples like lattice parameters, volume of the unit cell, crystallite size, bulk density of the samples, X-ray density and porosity of the samples.

Keywords: Ferrites; Sol-gel method; X-Ray diffraction; Crystal structure.

© 2013 JSR Publications. ISSN: 2070-0237 (Print); 2070-0245 (Online). All rights reserved. doi: <u>http://dx.doi.org/10.3329/jsr.v5i2.11578</u> J. Sci. Res. **5** (2), 235-244 (2013)

1. Introduction

Strontium hexaferrites are the prominent magnetic materials due to their supreme applications in diversity of fields. Their latest use in recording media and microwave devices provided them distinctive ranking in the list of magnetic materials. Owing to their excellent chemical stability and easy and low cost manufacturing, these are being synthesized by variety of methods [1]. Besides co-precipitation, microemulsion [2] and conventional ceramic methods [3], these ferrites are also being synthesized by sol-gel technique [4]. The spectacular properties of these ferrites can be tuned according to the requirement, with the assistance of fundamental doping process. Doping of some appropriate element in a particular proportion can play a vital role in altering the astonishing properties of the materials. For example, doping of Pb in $SrFe_{12}O_{19}$ lowers its coercivity and remanence due to which general behavior of these ferrites is changed [1, 5]. This is also true for many other soft ferrites [6, 7].

^{*} Corresponding author: shahidatiqpasrur@yahoo.com

236 Indexing the Diffraction Patterns

Crystal structure of the material controls its various properties [8]. Ferrites are classified with respect to their properties as well as crystal structure. Different types of ferrites like spinel, garnet and hexaferrites have different structures, varying from very easy to most complex [9]. Many scientists preceded their research work on investigation of crystal structure of $SrFe_{12}O_{19}$ and reported their detailed results. For instance, Fang *et al.* [10] determined the crystal structure of $SrFe_{12}O_{19}$ using density functional theory. The crystallographers have determined that the crystal structure of $SrFe_{12}O_{19}$ is hexagonal. Iqbal *et al.* [11] synthesized Zr-Zn doped $SrFe_{12}O_{19}$ and determined its lattice parameters, unit cell volume, crystallite size, bulk density, X-ray density and porosity by analyzing diffraction patterns.

To investigate the material properties, it is necessary to know about its structure. Without attaining the knowledge of crystal structure of the materials, it becomes very hard to investigate its properties [8]. In the present paper, X-ray diffraction analysis of the compositions $Sr_{1-x}Pb_xFe_{12}O_{19}$ (x = 0, 0.05, 0.1, 0.15, 0.2) has been discussed in details. A complete procedure of indexing and calculating various parameters related to this technique are explained in a simple way. This knowledge will provide a way to make a precise analysis of diffraction patterns of the other materials.

2. Experimental Procedure

Sol-gel auto-combustion technique was used for the preparation of various compositions of Pb-doped SrFe₁₂O₁₉. For the preparation of compositions $Sr_{1-x}Pb_xFe_{12}O_{19}$ (x = 0, 0.05, 0.1, 0.15, 0.2), required proportion of the metal nitrates and citric acid were measured with the help of a precise digital balance. All the materials were in powder form. Strontium nitrate (99%), iron (III) nitrate (98%), lead (II) nitrate (99%) and citric acid (99.5%) were dissolved in de-ionized water separately, and then mixed to make a total volume of 50 ml. pH-meter measured the pH of the solution as 2.5.

The magnetic capsule (stirrer) was put in the solution and beaker was placed on a hotplate. The setup was housed in an ESCO fume hood. Stirring of solution was started and temperature of the hotplate was increased gradually up to 150 °C. The solution was heated and stirred for about 45 minutes, till the gel was formed. As the gel was formed, the temperature of the sample was further increased up to 250° C. The gel was heated at this temperature for about 30 minutes when its combustion was started. It was allowed to combust normally. The sample took about 30 minutes for its complete combustion. During this interval, various gases were evolved from the beaker. The end product was a homogenous dry powder.

After complete combustion of the sample, the temperature of the hotplate was decreased gradually. Within 10 minutes, the hotplate was switched off and the sample was cooled down in air at room temperature. Although, the material was already in powder form but it became very fine after grinding, using an Agate mortar and pestle. Fine powder was put in the sample bottle. All the compositions were prepared in the same way. The samples were sintered at 800 $^{\circ}$ C for two hours in a muffle furnace. The prepared

samples were analyzed for the crystal structure, using the diffraction pattern, obtained from X-ray diffraction (XRD).

3. Results and Discussion

Data obtained from XRD for the first sample (x = 0) has been plotted in Fig. 1. The first task is to determine the crystal structure of the sample using this data. It is very tough job to determine the crystal structure of some unknown material, than that of a known one. In a diffraction pattern, the pattern of diffracted lines tells about the crystal structure, the positions of lines have information about the unit cell and the positions of the atoms can be judged by the intensities of the lines [8].



Fig. 1. Plot of data received from X-ray diffractometer.

From the XRD pattern shown in Fig. 1, it is expected that it is the diffraction pattern of hexagonal $SrFe_{12}O_{19}$. The first step is to index this pattern that will tell about the crystal system, to which the material is belonged. For this, the values of $\sin^2\theta$ are calculated for all major diffraction lines, as tabulated in Table 1. These values provide a base to solve the pattern. If there are some diffraction lines due to impurities in material or due to other reasons, then it creates problems and needs extra skills to tackle them.

A relation is developed by combing plane-spacing equation and Bragg's law equation, which determines the Miller indices of some specific crystal system. Suppose, for a cubic system, this expression can be written as [8]:

$$\frac{\sin^2\theta}{(h^2+k^2+l^2)} = \frac{\sin^2\theta}{s} = \frac{\lambda^2}{4a^2} \tag{1}$$

Here $\frac{\lambda^2}{4a^2}$ is a constant and $s = h^2 + k^2 + l^2$, which is determined by $sin^2\theta$ values.

For an unknown material, it has to be found that the values of $\sin^2\theta$ are integral multiple of which *hkl* values? First, we check the *hkl* values of a cubic system. If these do not satisfy, then we try for the other systems like tetragonal, hexagonal, etc. one by one. As the pattern under present study is expected to be of hexagonal crystal structure, hence it should obey the modified form of Eq. (1), given as [8]:

$$\sin^2\theta = A(h^2 + hk + k^2) + Cl^2 \tag{2}$$

Here, $A = \frac{\lambda^2}{3a^2}$ and $C = \frac{\lambda^2}{4c^2}$. The value of 'A' can be obtained at $hk\theta$ $(l = \theta)$. Hence, the permissible values of $(h^2 + hk + k^2)$ are 1, 3, 4, 7, 9, etc. Therefore, the values of $sin^2\theta$ in Table 1, were divided by 1, 3, 4, 7, etc. to get hkl values for hexagonal system, as shown in Table 2. Lattice parameter 'a' is calculated for all values of $sin^2\theta$. There is some order in particular values of 'a', being integral multiple of each other. Least value from them is the value of 'a' for 100 plane. Value a/2 is value of 'a' for 200 plane, and a/3 for 300 plane and so on.

Table 1. Diffraction lines and their corresponding angles taken from diffraction plot.

	20	0	a: 0	. 20
Line	2θ	θ	Sin $ heta$	$\sin^2 \theta$
1	23.10	11.55	0.2002	0.0401
2	25.5	12.75	0.2207	0.0487
3	29.00	14.50	0.2504	0.0627
4	30.30	15.15	0.2613	0.0683
5	30.90	15.45	0.2664	0.0710
6	32.33	16.165	0.2784	0.0775
7	34.15	17.075	0.2936	0.0862
8	35.20	17.60	0.3024	0.0914
9	35.41	17.705	0.3041	0.0925
10	36.50	18.25	0.3132	0.0981
11	37.10	18.55	0.3181	0.1012
12	40.40	20.20	0.3453	0.1192
13	42.55	21.275	0.3628	0.1317
14	46.85	23.425	0.3975	0.1580
15	50.30	25.15	0.4250	0.1806
16	53.95	26.975	0.4536	0.2058
17	55.20	27.60	0.4633	0.2146
18	56.80	28.40	0.4756	0.2262
19	63.15	31.575	0.5236	0.2742
20	67.59	33.795	0.5562	0.3094

Generally, smallest repeating value in all columns is found and is considered to be 'A'. Lattice parameter is calculated for this value and crystal structure is determined. But sometimes, 'A' cannot be found for 100 plane, hence lattice parameter 'a' is calculated at hk0 for all $\sin^2\theta$ values, as was proceeded in the recent case. It is found that the diffraction line having $\sin^2\theta$ value of 0.0914, gave the most nearest value of 'a' for 200 plane. This repeating value was also found in the next column of Table 2, hence it was considered as 'A'. 'C' was determined by the following relation [8]:

$$\sin^2\theta - A(h^2 + hk + k^2) = Cl^2 \tag{3}$$

The values of *A*, *3A*, *4A*, etc. were subtracted from corresponding $\sin^2\theta$ values to find the remainders 1, 4, 9, 16, etc., as shown in Table 3. The value of '*C*' was found to be 0.0011. The corresponding value of $\sin^2\theta$ is combination of *2A* and *C*, hence *hkl* assigned to this value are 201. Such combinations (*A*+*C*, *2A*+*2C*, *3A*+*C*, *3A*+*2C*, etc.) of $\sin^2\theta$ values were found to assign *hkl* values to various diffraction lines. These *hkl* values are listed in the most right column of Table 3 and are shown in Fig. 2. These *hkl* values confirm that the diffraction pattern belongs to a hexagonal crystal structure. The lattice parameter '*c*' was calculated with the help of Eq. (4) [8]:

			3'	4 7	
Line	sin ² 0	$\sin^2\theta$	$\sin^2\theta$	$\sin^2\theta$	h k l
		3	4	7	
1	0.0401	0.0134	0.0100	0.0057	
2	0.0487	0.0162	0.0122	0.0070	
3	0.0627	0.0209	0.0157	0.0090	
4	0.0683	0.0228	0.0171	0.0098	
5	0.0710	0.0237	0.0177	0.0101	
6	0.0775	0.0258	0.0194	0.0111	
7	0.0862	0.0287	0.0216	0.0123	
8	0.0914	0.0305	0.0229	0.0131	$2\ 0\ 0$
9	0.0925	0.0308	0.0231	0.0132	
10	0.0981	0.0327	0.0245	0.0140	
11	0.1012	0.0337	0.0253	0.0145	
12	0.1192	0.0397	0.0298	0.0170	
13	0.1317	0.0439	0.0329	0.0188	
14	0.1580	0.0527	0.0395	0.0226	
15	0.1806	0.0602	0.0452	0.0258	
16	0.2058	0.0686	0.0514	0.0294	
17	0.2146	0.0715	0.0537	0.0307	
18	0.2262	0.0754	0.0566	0.0323	
19	0.2742	0.0914	0.0685	0.0392	
20	0.3094	0.1031	0.0773	0.0442	

Table 2. Values of $\sin^2\theta$ and its multiples (by $\frac{1}{2}, \frac{1}{4}, \frac{1}{7}$) to find out *hkl*.





Fig. 2. Indexing of X-ray diffraction pattern.

Line	$\sin^2 \theta$	$\sin^2\theta$ -A	$\sin^2\theta$ -3A	h k l
1	0.0401			006
2	0.0487			105
3	0.0627			106
4	0.0683			110
5	0.0710			008
6	0.0775			107
7	0.0862			114
8	0.0914	0.0000		200
9	0.0925	0.0011		201
10	0.0981	0.0067		202
11	0.1012	0.0098		203
12	0.1192	0.0278		205
13	0.1317	0.0403		206
14	0.1580	0.0666		1011
15	0.1806	0.0892		209
16	0.2058	0.1144		300
17	0.2146	0.1232		217
18	0.2262	0.1348		2011
19	0.2742	0.1828	0.0000	220
20	0.3094	0.2180	0.0352	2014

Table 3. Values of $\sin^2 \theta$ and subtracted ones to find out value of *C*.

The same procedure was repeated for indexing the patterns of all the compositions as shown in Fig. 3 and their lattice parameters were determined in the same way. These values are listed in Table 4. The results show that the lattice parameters 'a' and 'c' are increased with increase in Pb concentration, as shown in Fig. 4. These changes may be due to larger ionic radius of Pb^{2+} (12.0 nm) than that of Sr^{2+} (11.3 nm) [9]. The *c/a* ratio was also calculated for all the samples.



Fig. 3. X-ray diffraction patterns of all the samples

The volume of the unit cell was calculated by the relation as in ref. [13]:

$$V = \sqrt{3} \times a^2 \times \frac{c}{2} = 0.866 \ a^2 c \tag{5}$$

Unit cell volumes of all the samples are also given in Table 4. Due to increasing trend of lattice parameters 'a' and 'c', the volume of the unit cell is also increased with increasing Pb contents, as reported previously [12].

The crystallite size was measured for peak (114) using Scherrer's formula, given as [8]:

$$D = \frac{k\lambda}{\beta \cos\theta} \tag{6}$$

Here, 'D' is crystallite size, ' λ ' is wavelength of incident X-ray, ' β ' represents full width half maximum (FWHM) in radians, and ' θ ' is Bragg angle. 'k' is a shape factor, having value of 0.94 in the recent case. Crystallite size calculated for various

compositions is given in Table 4. It is clear that crystallite size is increased with increase in doping ratio, which might be due to larger ionic size of Pb^{2+} [12].

Although, there was no distinct peak of Pb in diffraction patterns of Pb-doped compositions, but the increase in lattice parameters, volume and crystallite size proves the presence of Pb. The bulk density of the material was calculated as in ref. [13]:

$$\rho_b = \frac{m}{\pi r^2 h} \tag{7}$$

In this relation, 'm' is mass, 'r' is radius of the pellet in disk form and 'h' is height or thickness of the sample. Bulk density for all the materials has been calculated and it is observed that its value is increased with increase of Pb concentration which is according to the previous results [12]. The X-ray density was determined with the help of following expression [13]:

$$\rho_x = \frac{2M}{N_A V} \tag{8}$$

where '*M*' is molecular weight of the material and it is multiplied by '2' because one unit cell contains two molecules of the material. ' N_A ' is Avogadro's number and '*V*' is volume of the unit cell, determined by Eq. (50.



Fig. 4. Effect of Pb doping on lattice parameters.

The calculated values of X-ray density are tabulated in Table 4. Now, porosity of the material can easily be determined by Eq. (8) [13]:

$$P = 1 - \frac{\rho_b}{\rho_x} \tag{9}$$

The calculated values of porosity for all the samples are given in Table 4.

Table 4. Calculated values of lattice parameters 'a' and 'c', c/a ratio, volume of the unit cell (V), crystallite size (D), bulk density of the material (ρ_b), X-ray density (ρ_x) and porosity (P) of the material.

Parameter	x = 0.00	<i>x</i> = 0.05	<i>x</i> = 0.10	<i>x</i> = 0.15	<i>x</i> = 0.20
a (Å)	5.8802	5.8822	5.8852	5.8874	5.8908
<i>c</i> (Å)	23.2018	23.2141	23.2192	23.2254	23.2358
c/a	3.9463	3.9463	3.9448	3.9448	3.9448
$V(nm^3)$	69.4742	69.5584	69.6446	69.7153	69.8271
<i>D</i> (nm)	29.9270	32.1438	32.5481	33.1472	34.7200
$\rho_b(g/cm^3)$	2.63	2.76	2.89	2.94	3.01
$\rho_x (g/cm^3)$	5.08	5.10	5.12	5.14	5.16
Р	0.4823	0.4588	0.4356	0.4280	0.4167

4. Conclusion

Sr-hexaferrites were prepared by sol-gel auto-ignition technique and were studied for their crystal structure investigation. A complete procedure to determine the crystal structure from X-ray diffraction data has been described and crystal structure of the given material has been found. It was observed that the lattice parameters 'a' and 'c' were increased with increase in doping concentration; hence volume of the unit cell was also increased. This was due to large ionic size of Pb than that of Sr. Crystallite size was increased from 29.93 nm to 34.72 nm. Bulk density of the material, X-ray density and porosity were calculated for various compositions of Pb-doped Sr hexaferrites. On increasing bulk and X-ray density values, the porosity decreased from 0.4823 to 0.4167.

References

- 1. S. Hussain, A. Maqsood, A. Ali, and M. Naeem, J. Supercond. Nov. Magn. **24**, 1245 (2011). http://dx.doi.org/10.1007/s10948-010-1115-z
- 2. A. Drmota, M. Drofenik, and A. Znidarsic, Ceram Int. **38**, 973 (2012). http://dx.doi.org/10.1016/j.ceramint.2011.08.018
- W. Onreabroy, K. Papato, G. Rujijanagul, K. Pengpat, and T. Tunkasiri, Ceram Int. 38S, S415 (2012). <u>http://dx.doi.org/10.1016/j.ceramint.2011.05.023</u>
- 4. R. Martinez Garcia, V. Bilovol, and L. M. Socolovsky, Physica B **407**, 3109 (2011). http://dx.doi.org/10.1016/j.physb.2011.12.038
- Z. Ullah, S. Atiq, and S. Naseem, J. Alloys Compd. 555, 263 (2013). http://dx.doi.org/10.1016/j.jallcom.2012.12.061

- M. M. Rahman, P. K. Halder, F. Ahmed, T. Hossain, and M. Rahaman, J. Sci. Res. 4 (2), 297 (2012). <u>http://dx.doi.org/10.3329/jsr.v4i2.9752</u>
- S. Akhter, D. P. Paul, M. A. Hakim, S. Akhter, D. K. Saha, B. Anjuman, and F. Islam, J. Sci. Res. 4 (3), 551 (2012). <u>http://dx.doi.org/10.3329/jsr.v4i3.10798</u>
- 8. B. D. Cullity, Elements of X-ray Diffraction, 2nd Ed., (Addison-Wesley, Manila, Philippines, 1978) pp. 324-339.
- 9. C. B. Carter and M. G. Norton, Ceramic Materials/Science and Engineering (Springer, New York, 2007) pp. 101-108.
- C. M. Fang, F. Kools, R. Metselaar, G. de With, and R. A. de Groot, J. Phys.: Condens. Matter 15, 6229 (2003). <u>http://dx.doi.org/10.1088/0953-8984/15/36/311</u>
- 11. M. J. Iqbal, M. N. Ashiq, and P. H. Gomez, J. Alloys Compd. **478**, 736 (2009). <u>http://dx.doi.org/10.1016/j.jallcom.2008.11.136</u>
- S. Hussain, and A. Maqsood, J. Alloys Compd. 466, 293 (2008). http://dx.doi.org/10.1016/j.jallcom.2007.11.074
- 13. S. Hussain and A. Maqsood, J. Magn. Magn. Mater. **316**, 73 (2007). http://dx.doi.org/10.1016/j.jmmm.2007.03.206